

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/016,199 BEAN ET AL.	
		Examiner	Art Unit	Page 1 of 1 James M. Hannett

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0018137	02-2002	Tsuda, Yutaka	348/333.02
	B	US-5,790,878	08-1998	Anderson et al.	713/340
	C	US-6,710,809	03-2004	Niikawa, Masahito	348/372
	D	US-2002/0154243	10-2002	Fife et al.	348/372
	E	US-6,327,001	12-2001	Yamagishi, Yoichi	348/552
	F	US-5,359,728	10-1994	Rusnack et al.	714/5
	G	US-6,263,453	07-2001	Anderson, Eric C.	714/22
	H	US-5,963,255	10-1999	Anderson et al.	348/372
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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